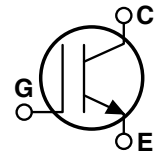
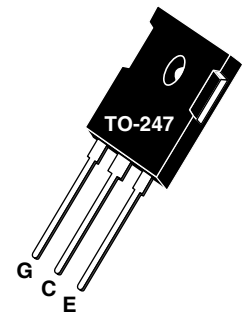


### POWER MOS 7® IGBT

The POWER MOS 7® IGBT is a new generation of high voltage power IGBTs. Using Punch Through Technology this IGBT is ideal for many high frequency, high voltage switching applications and has been optimized for high frequency switchmode power supplies.

- Low Conduction Loss
- Low Gate Charge
- Ultrafast Tail Current shutoff
- SSOA rated




#### MAXIMUM RATINGS

All Ratings:  $T_C = 25^\circ\text{C}$  unless otherwise specified.

Symbol	Parameter	APT26GU30B	UNIT
$V_{CES}$	Collector-Emitter Voltage	300	Volts
$V_{GE}$	Gate-Emitter Voltage	$\pm 20$	
$V_{GEM}$	Gate-Emitter Voltage Transient	$\pm 30$	
$I_{C1}$	Continuous Collector Current @ $T_C = 25^\circ\text{C}$	47	Amps
$I_{C2}$	Continuous Collector Current @ $T_C = 100^\circ\text{C}$	26	
$I_{CM}$	Pulsed Collector Current <sup>①</sup> @ $T_C = 150^\circ\text{C}$	85	
SSOA	Switching Safe Operating Area @ $T_J = 150^\circ\text{C}$	85A @ 300V	
$P_D$	Total Power Dissipation	187	Watts
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to 150	$^\circ\text{C}$
$T_L$	Max. Lead Temp. for Soldering: 0.063" from Case for 10 Sec.	300	

#### STATIC ELECTRICAL CHARACTERISTICS

Symbol	Characteristic / Test Conditions	MIN	TYP	MAX	UNIT
$BV_{CES}$	Collector-Emitter Breakdown Voltage ( $V_{GE} = 0\text{V}, I_C = 250\mu\text{A}$ )	300			Volts
$V_{GE(TH)}$	Gate Threshold Voltage ( $V_{CE} = V_{GE}, I_C = 1\text{mA}, T_J = 25^\circ\text{C}$ )	3	4.5	6	
$V_{CE(ON)}$	Collector-Emitter On Voltage ( $V_{GE} = 15\text{V}, I_C = 13\text{A}, T_J = 25^\circ\text{C}$ )		1.5	2.0	
	Collector-Emitter On Voltage ( $V_{GE} = 15\text{V}, I_C = 13\text{A}, T_J = 125^\circ\text{C}$ )		1.5		
$I_{CES}$	Collector Cut-off Current ( $V_{CE} = V_{CES}, V_{GE} = 0\text{V}, T_J = 25^\circ\text{C}$ ) <sup>②</sup>			250	$\mu\text{A}$
	Collector Cut-off Current ( $V_{CE} = V_{CES}, V_{GE} = 0\text{V}, T_J = 125^\circ\text{C}$ ) <sup>②</sup>			2500	
$I_{GES}$	Gate-Emitter Leakage Current ( $V_{GE} = \pm 20\text{V}$ )			$\pm 100$	nA

 **CAUTION:** These Devices are Sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.

**DYNAMIC CHARACTERISTICS**

**APT26GU30B**

Symbol	Characteristic	Test Conditions	MIN	TYP	MAX	UNIT
$C_{ies}$	Input Capacitance	<b>Capacitance</b> $V_{GE} = 0V, V_{CE} = 25V$ $f = 1\text{ MHz}$		1200		pF
$C_{oes}$	Output Capacitance			120		
$C_{res}$	Reverse Transfer Capacitance			6		
$V_{GEP}$	Gate-to-Emitter Plateau Voltage	<b>Gate Charge</b> $V_{GE} = 15V$ $V_{CE} = 150V$ $I_C = 13A$		7.0		V
$Q_g$	Total Gate Charge <sup>③</sup>			37		nC
$Q_{ge}$	Gate-Emitter Charge			8		
$Q_{gc}$	Gate-Collector ("Miller") Charge			10		
SSOA	Switching Safe Operating Area	$T_J = 150^\circ\text{C}, R_G = 5\Omega, V_{GE} = 15V, L = 100\mu\text{H}, V_{CE} = 300V$	85			A
$t_{d(on)}$	Turn-on Delay Time	<b>Inductive Switching (25°C)</b> $V_{CC} = 200V$ $V_{GE} = 15V$ $I_C = 13A$ $R_G = 20\Omega$ $T_J = +25^\circ\text{C}$		11		ns
$t_r$	Current Rise Time			14		
$t_{d(off)}$	Turn-off Delay Time			60		
$t_f$	Current Fall Time			55		
$E_{on1}$	Turn-on Switching Energy <sup>④</sup>				TBD	μJ
$E_{on2}$	Turn-on Switching Energy (Diode) <sup>⑤</sup>				48	
$E_{off}$	Turn-off Switching Energy <sup>⑥</sup>			60		
$t_{d(on)}$	Turn-on Delay Time	<b>Inductive Switching (125°C)</b> $V_{CC} = 200V$ $V_{GE} = 15V$ $I_C = 13A$ $R_G = 20\Omega$ $T_J = +125^\circ\text{C}$		11		ns
$t_r$	Current Rise Time			14		
$t_{d(off)}$	Turn-off Delay Time			70		
$t_f$	Current Fall Time			100		
$E_{on1}$	Turn-on Switching Energy <sup>④</sup>				TBD	μJ
$E_{on2}$	Turn-on Switching Energy (Diode) <sup>⑤</sup>				80	
$E_{off}$	Turn-off Switching Energy <sup>⑥</sup>			95		

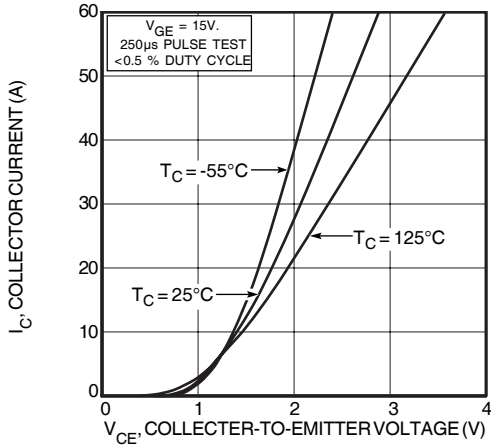
**THERMAL AND MECHANICAL CHARACTERISTICS**

Symbol	Characteristic	MIN	TYP	MAX	UNIT
$R_{\theta JC}$	Junction to Case (IGBT)			0.67	°C/W
$R_{\theta JC}$	Junction to Case (DIODE)			N/A	
$W_T$	Package Weight			5.9	gm

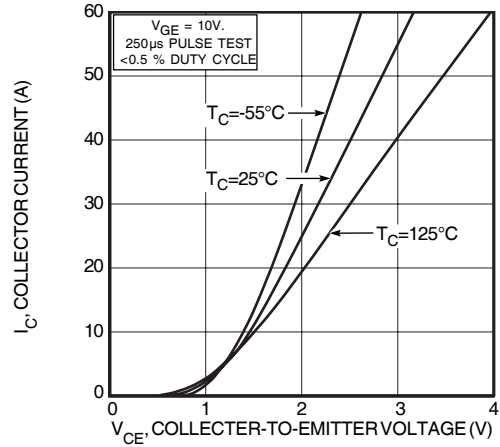
- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
  - ② For Combi devices,  $I_{ces}$  includes both IGBT and FRED leakages
  - ③ See MIL-STD-750 Method 3471.
  - ④  $E_{on1}$  is the clamped inductive turn-on-energy of the IGBT only, without the effect of a commutating diode reverse recovery current adding to the IGBT turn-on loss. (See Figure 24.)
  - ⑤  $E_{on2}$  is the clamped inductive turn-on energy that includes a commutating diode reverse recovery current in the IGBT turn-on switching loss. A Combi device is used for the clamping diode as shown in the  $E_{on2}$  test circuit. (See Figures 21, 22.)
  - ⑥  $E_{off}$  is the clamped inductive turn-off energy measured in accordance with JEDEC standard JESD24-1. (See Figures 21, 23.)
- APT Reserves the right to change, without notice, the specifications and information contained herein.**

**TYPICAL PERFORMANCE CURVES**

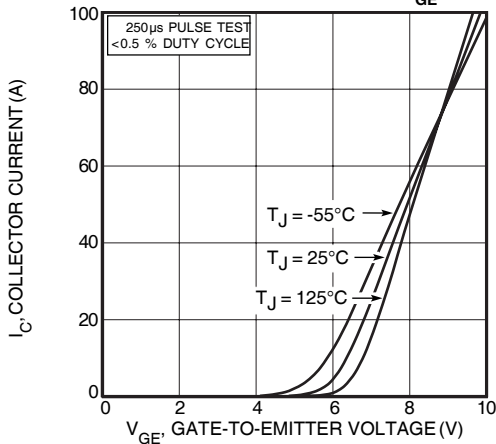
**APT26GU30B**



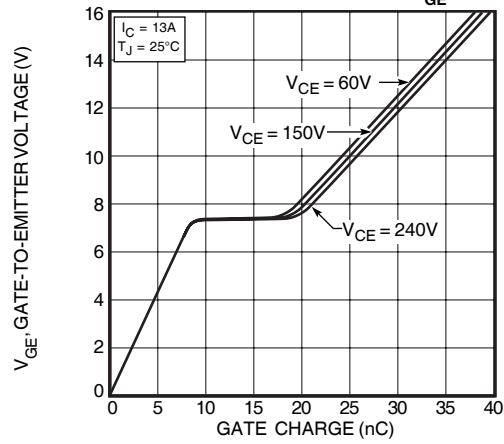
**FIGURE 1, Output Characteristics ( $V_{GE} = 15V$ )**



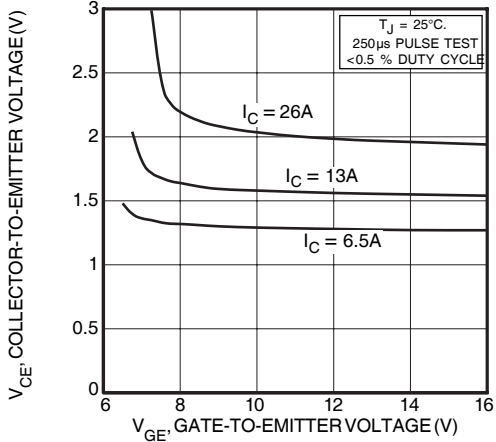
**FIGURE 2, Output Characteristics ( $V_{GE} = 10V$ )**



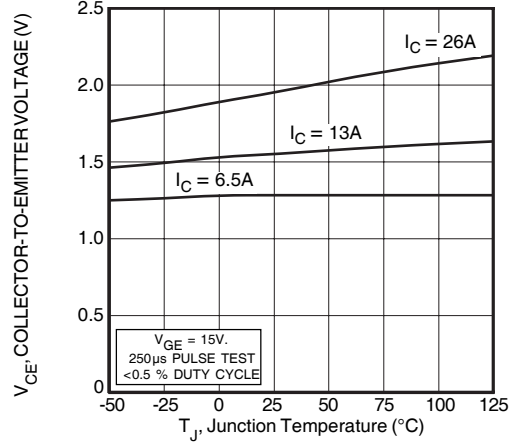
**FIGURE 3, Transfer Characteristics**



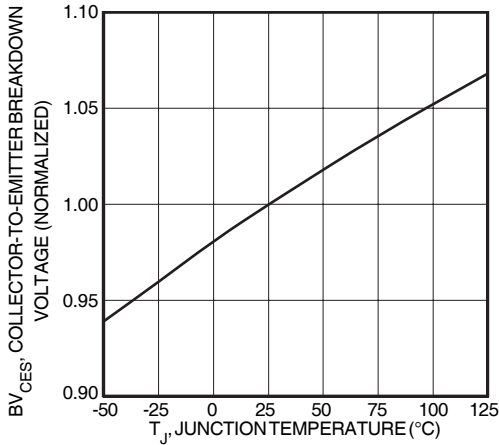
**FIGURE 4, Gate Charge**



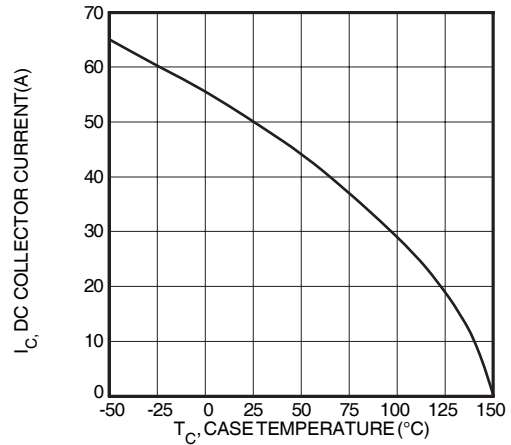
**FIGURE 5, On State Voltage vs Gate-to-Emitter Voltage**



**FIGURE 6, On State Voltage vs Junction Temperature**



**FIGURE 7, Breakdown Voltage vs. Junction Temperature**



**FIGURE 8, DC Collector Current vs Case Temperature**

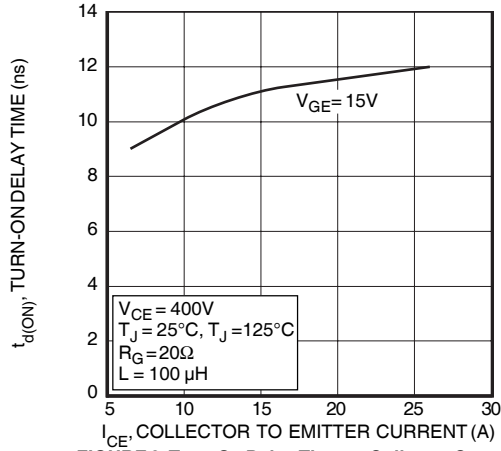


FIGURE 9, Turn-On Delay Time vs Collector Current

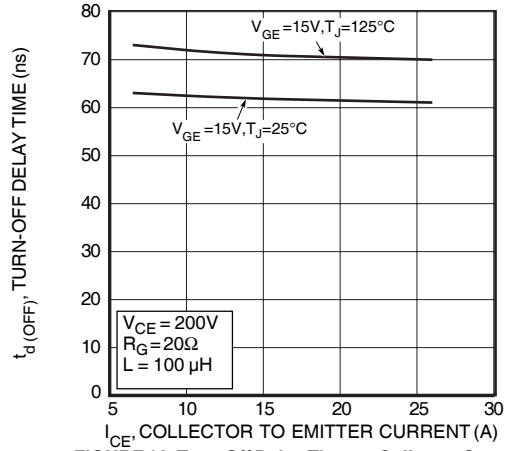


FIGURE 10, Turn-Off Delay Time vs Collector Current

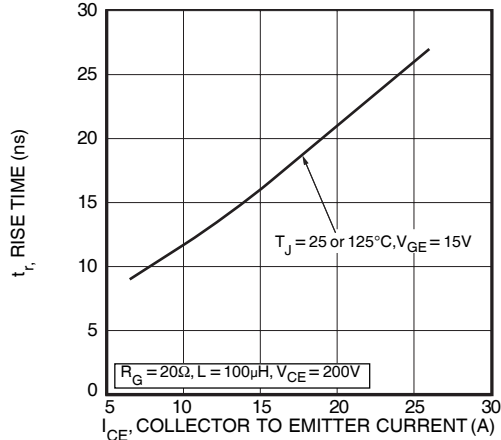


FIGURE 11, Current Rise Time vs Collector Current

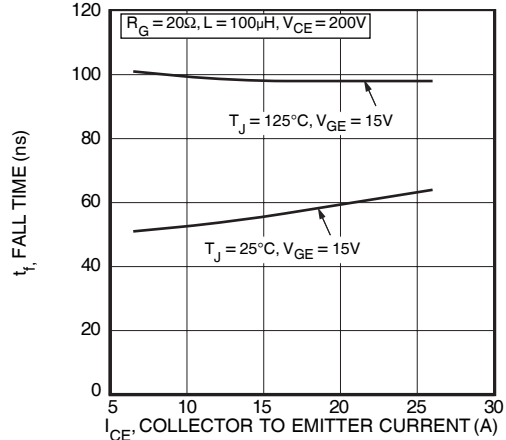


FIGURE 12, Current Fall Time vs Collector Current

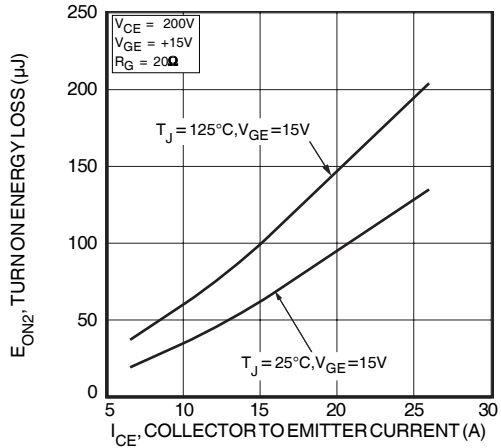


FIGURE 13, Turn-On Energy Loss vs Collector Current

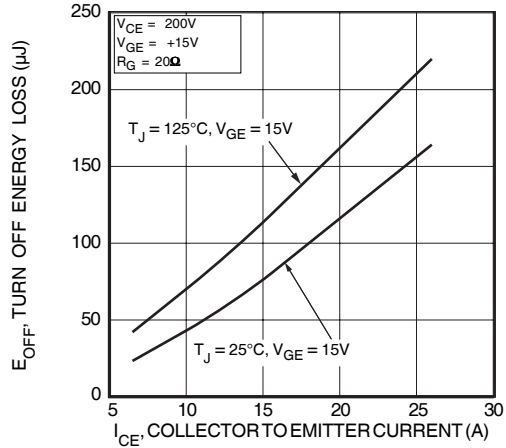


FIGURE 14, Turn Off Energy Loss vs Collector Current

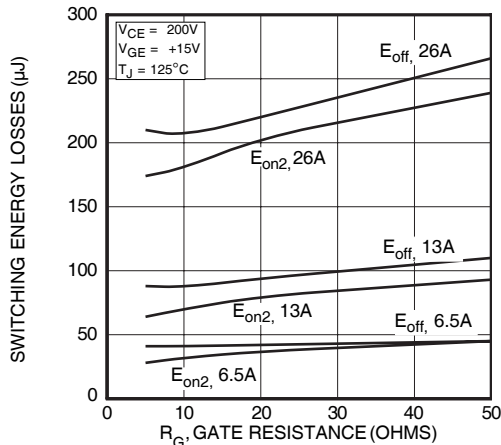


FIGURE 15, Switching Energy Losses vs. Gate Resistance

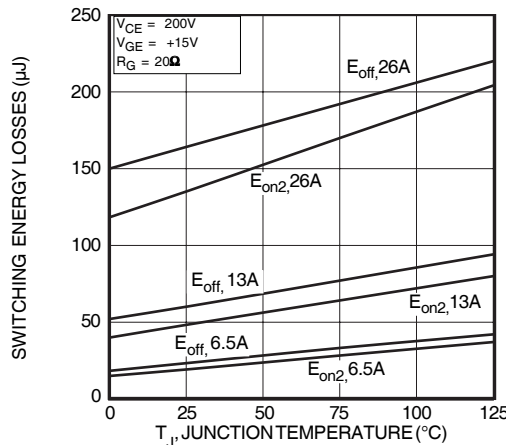
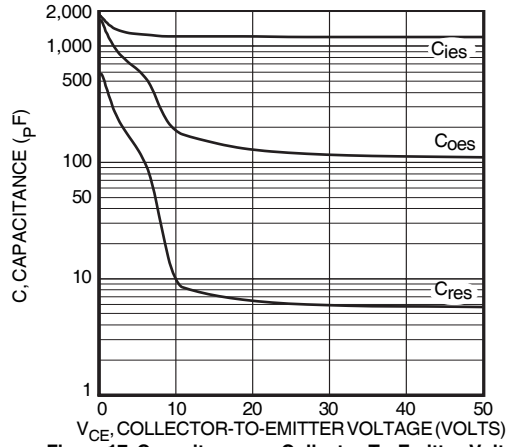


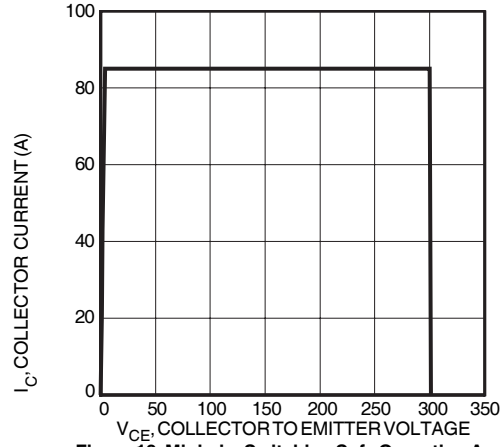
FIGURE 16, Switching Energy Losses vs Junction Temperature

**TYPICAL PERFORMANCE CURVES**

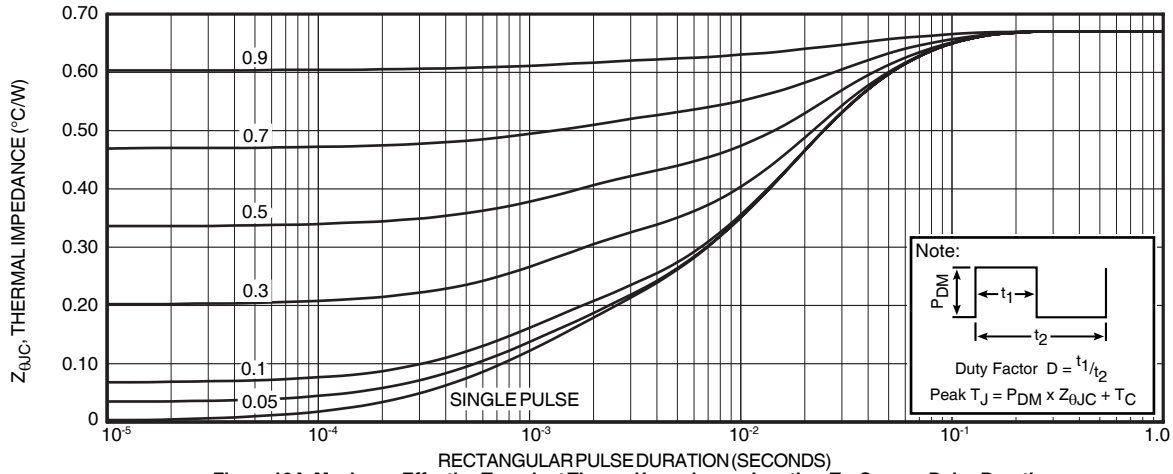
**APT26GU30B**



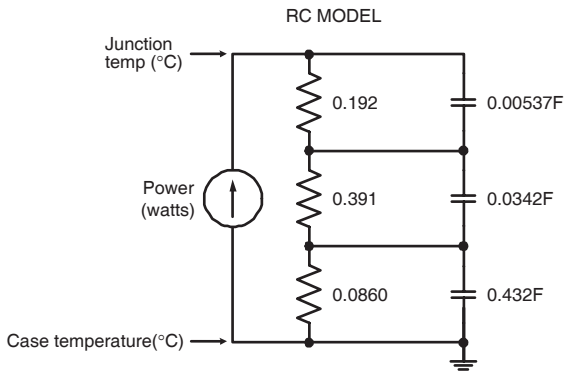
**Figure 17, Capacitance vs Collector-To-Emitter Voltage**



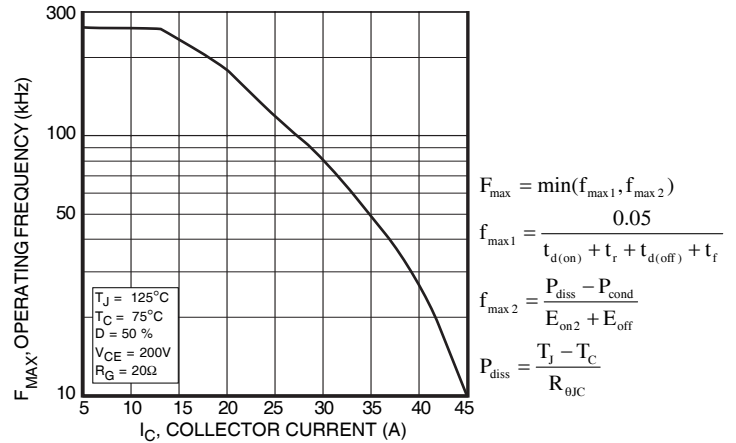
**Figure 18, Minimum Switching Safe Operating Area**



**Figure 19A, Maximum Effective Transient Thermal Impedance, Junction-To-Case vs Pulse Duration**



**FIGURE 19B, TRANSIENT THERMAL IMPEDANCE MODEL**



**Figure 20, Operating Frequency vs Collector Current**

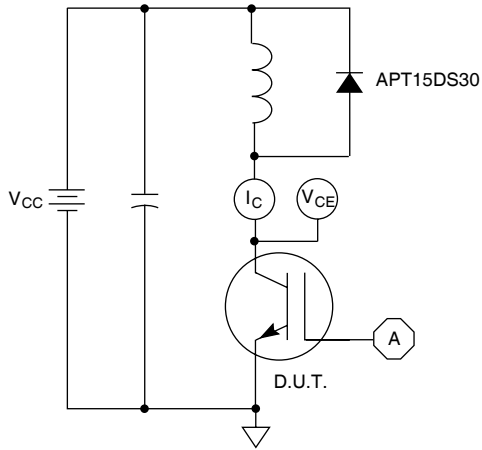


Figure 21, Inductive Switching Test Circuit

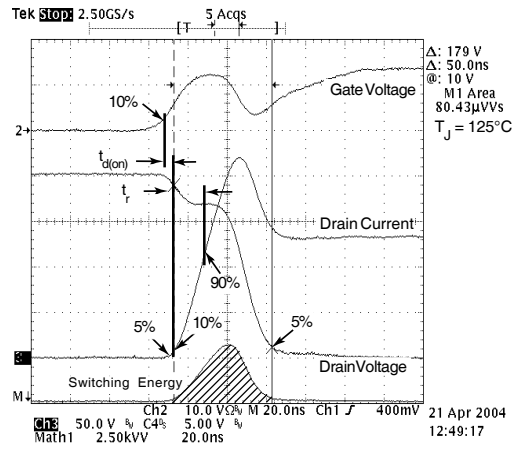


Figure 22, Turn-on Switching Waveforms and Definitions

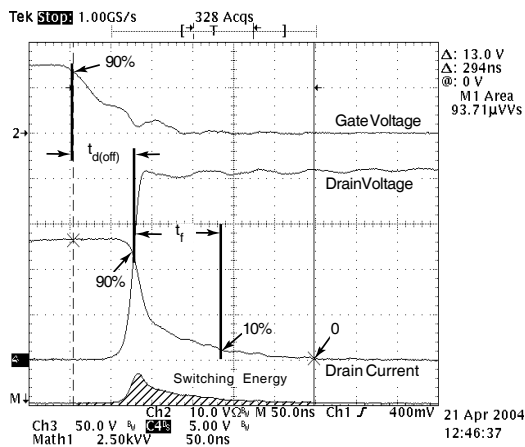


Figure 23, Turn-off Switching Waveforms and Definitions

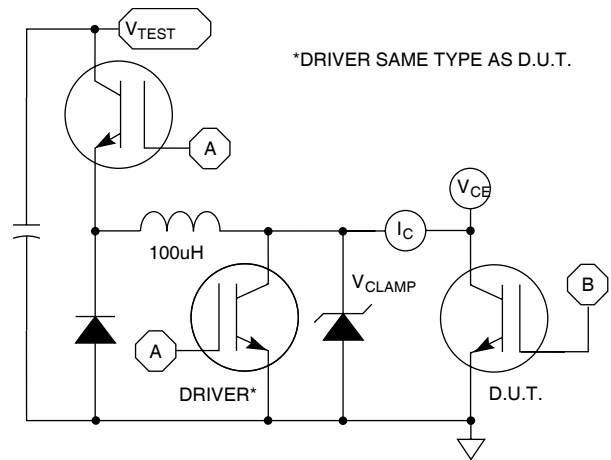
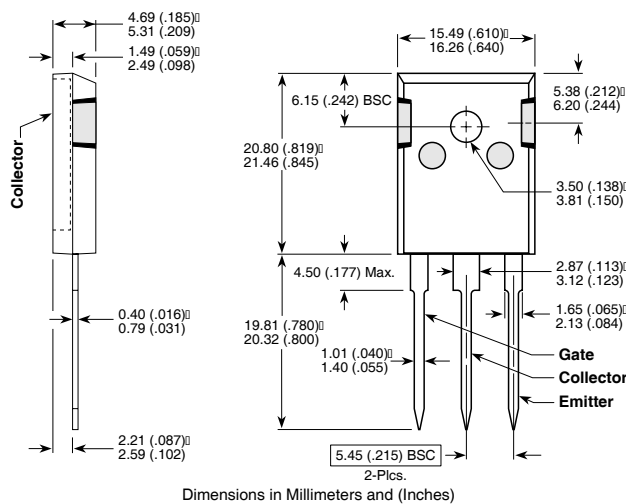


Figure 24, E<sub>ON1</sub> Test Circuit

T0-247 Package Outline



Dimensions in Millimeters and (Inches)



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